

**Search Notes**

Application/Control No.

10/687,924

Examiner

Harold Kim

Applicant(s)/Patent under  
Reexamination

FLAUTNER ET AL.

Art Unit

2182

**SEARCHED**

Class	Subclass	Date	Examiner
713	320-322	1/26/2006	HK
702	182, 183	1/26/2006	HK
710	15	1/26/2006	HK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, USPGPUB, JPO, EPO, IEEE, NPL, see attached search note	1/26/2006	HK
Inventor search on eDAN	1/26/2006	HK

*Harold Kim 1/26/2006*